April 1999

# **FDS6961A** Dual N-Channel Logic Level PowerTrench<sup>™</sup> MOSFET

### **General Description**

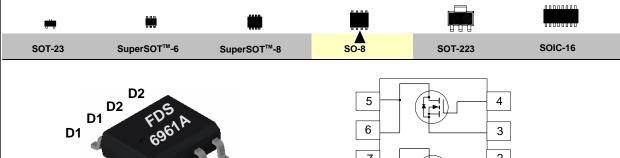
FAIRCHILD

These N-Channel Logic Level MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

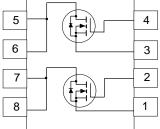
# Features

- $\begin{array}{c|c} \bullet & 3.5 \text{ A}, \ 30 \ \text{V}. \ \text{R}_{\text{DS(ON)}} = 0.090 \ \Omega & @ \ \text{V}_{\text{GS}} = 10 \ \text{V} \\ & \text{R}_{\text{DS(ON)}} = 0.140 \ \Omega & @ \ \text{V}_{\text{GS}} = 4.5 \ \text{V}. \end{array}$
- Fast switching speed.
- Low gate charge (2.1nC typical).
- High performance trench technology for extremely low  $\mathsf{R}_{\mathsf{DS}(\mathsf{ON})}.$
- High power and current handling capability.



G2 S2





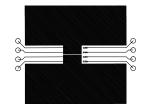
### **Absolute Maximum Ratings** $T_a = 25^{\circ}C$ unless other wise noted

Symbol	Parameter	Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage	30	V
V <sub>GSS</sub>	Gate-Source Voltage	±20	V
I <sub>D</sub>	Drain Current - Continuous (Note 1a)	3.5	А
	- Pulsed	14	
P <sub>D</sub>	Power Dissipation for Single Operation (Note 1)	2	W
	Power Dissipation for Single Operation (Note 1a)	1.6	
	(Note 1b)	1	
	(Note 1c)	0.9	
T_,,T <sub>stg</sub>	Operating and Storage Temperature Range	-55 to 150	°C
THERMA	L CHARACTERISTICS		
R <sub>eja</sub>	Thermal Resistance, Junction-to-Ambient (Note 1a)	78	°C/W
R <sub>euc</sub>	Thermal Resistance, Junction-to-Case (Note 1)	40	°C/W

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Symbol	Parameter	Conditions	Min	Тур	Max	Units
OFF CHAR	ACTERISTICS		•	•	•	•
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_{D} = 250 \mu A$	30			V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient	$I_D = 250 \mu\text{A}$ , Referenced to 25 °C		25		mV/ºC
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24 V, V_{GS} = 0 V$			1	μA
		$T_{J} = 55^{\circ}C$			10	μA
	Gate - Body Leakage, Forward	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V			100	nA
	Gate - Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			-100	nA
	CTERISTICS (Note 2)	·				
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1	1.8	3	V
$\Delta V_{GS(th)} / \Delta T_J$	Gate Threshold Voltage Temp. Coefficient	$I_{\rm D}$ = 250 µA, Referenced to 25 °C		-5		mV/°C
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 3.5 \text{ A}$		0.076	0.09	Ω
		T, =125°C		0.11	0.155	
		$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 2.8 \text{ A}$		0.107	0.14	
I <sub>D(ON)</sub>	On-State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 5 \text{ V}$	14			Α
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 15 \text{ V}, \text{ I}_{D} = 3.5 \text{ A}$		6		S
Dynamic (	HARACTERISTICS					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 V, V_{GS} = 0 V,$ f = 1.0 MHz		220		pF
C <sub>oss</sub>	Output Capacitance			50		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			20		pF
SWITCHING	CHARACTERISTICS (Note 2)		-	•	•	
t <sub>D(on)</sub>	Turn - On Delay Time	$V_{DS} = 15 \text{ V}, \text{ I}_{D} = 1 \text{ A}$		3	6	ns
t,	Turn - On Rise Time	$V_{GS} = 10 \text{ V}$ , $R_{GEN} = 6 \Omega$		11	22	ns
t <sub>D(off)</sub>	Turn - Off Delay Time			7	14	ns
t <sub>r</sub>	Turn - Off Fall Time			3	6	ns
Q <sub>g</sub>	Total Gate Charge	$V_{\rm DS} = 15 \text{ V}, \ \text{I}_{\rm D} = 3.5 \text{ A},$		2.1	4	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = 5 V$		0.8		nC
$Q_{gd}$	Gate-Drain Charge			0.7		nC
DRAIN-SOU	RCE DIODE CHARACTERISTICS AND MAXIMU	JM RATINGS				
s	Maximum Continuous Drain-Source Diode Fo	ximum Continuous Drain-Source Diode Forward Current			1.3	Α
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 V, I_{S} = 1.3 A$ (Note 2)		0.73	1.2	V

1. R<sub>gut</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>gut</sub> is guaranteed by design while R<sub>gut</sub> is determined by the user's board design.

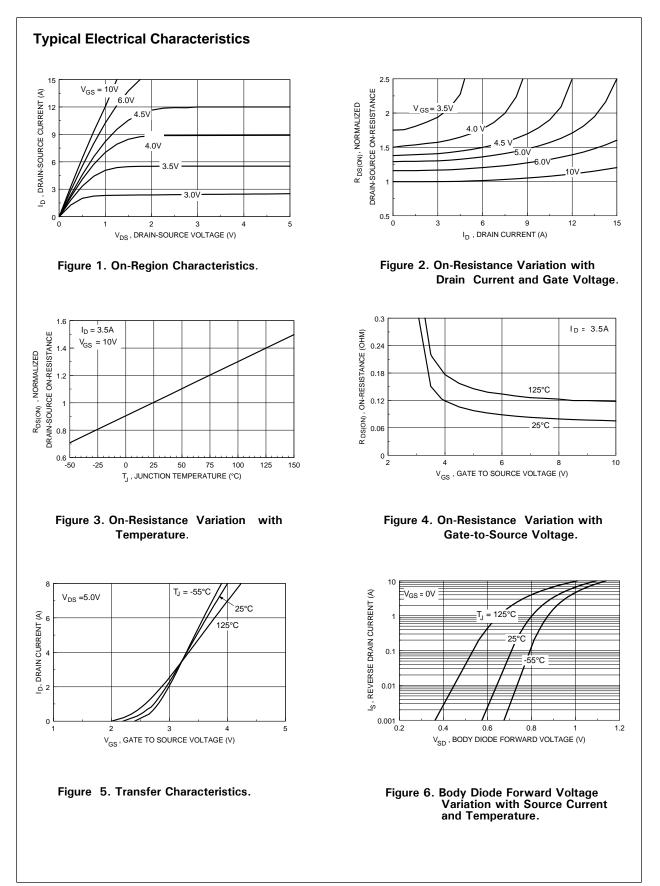


a. 78°C/W on a 0.5 in<sup>2</sup> pad of 2oz copper.

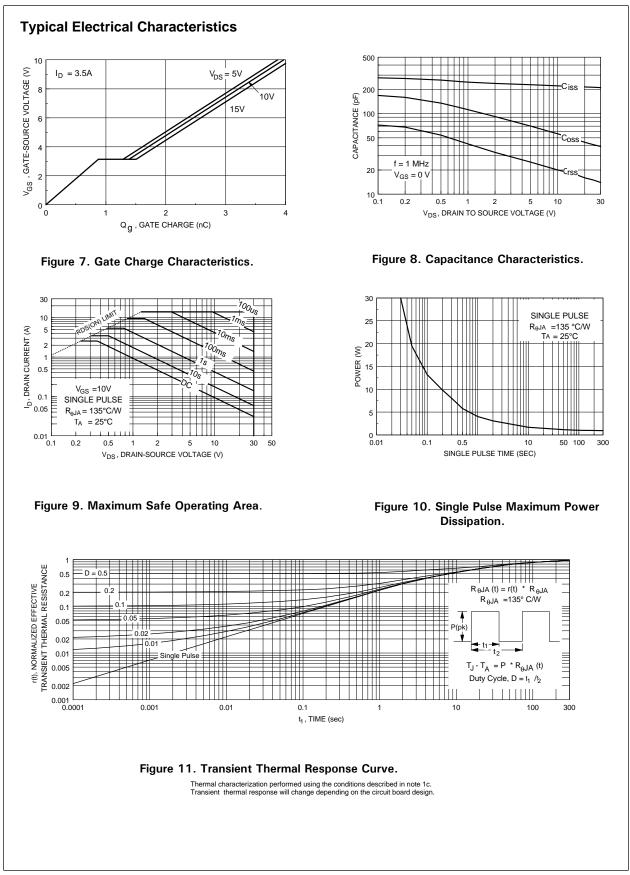
b. 125°C/W on a 0.02 in<sup>2</sup> pad of 202 copper.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width  $\leq$  300µs, Duty Cycle  $\leq$  2.0%.



FDS6961A Rev.C



FDS6961A Rev.C

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